

MOS FIELD EFFECT TRANSISTOR μ**PA1853**

P-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

DESCRIPTION

The μ PA1853 is a switching device which can be driven directly by a 4-V power source.

The μPA1853 features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

FEATURES

- Can be driven by a 4-V power source
- · Low on-state resistance $R_{DS(on)1} = 85 \text{ m}\Omega \text{ MAX.} (V_{GS} = -10 \text{ V}, \text{ ID} = -1.5 \text{ A})$ $R_{DS(on)2} = 152 \text{ m}\Omega \text{ MAX.} (V_{GS} = -4.5 \text{ V}, \text{ ID} = -1.5 \text{ A})$ $R_{DS(on)3} = 180 \text{ m}\Omega \text{ MAX.} (V_{GS} = -4.0 \text{ V}, \text{ ID} = -1.5 \text{ A})$

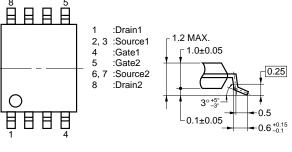
ORDERING INFORMATION

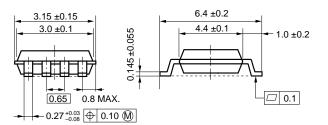
PART NUMBER	PACKAGE
μPA1853GR-9JG	Power TSSOP8

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^{\circ}C$)

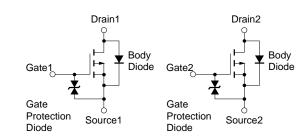
Drain to Source Voltage	VDSS	-30
Gate to Source Voltage	Vgss	-20/+5
Drain Current (DC)	D(DC)	+ 2.5
Drain Current (pulse) Note1	D(pulse)	∓ 10
Total Power Dissipation Note2	Рт	2.0
Channel Temperature	Tch	150
Storage Temperature	Tstg	–55 to +150

PACKAGE DRAWING (Unit : mm)





EQUIVALENT CIRCUIT



Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1 %

2. Mounted on ceramic substrate of 5000 mm² x 1.1 mm

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

V V

А

А

W °C

°C

The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version. Not all devices/types available in every country. Please check with local NEC representative for availability and additional information

Document No Date Published Printed in Japan

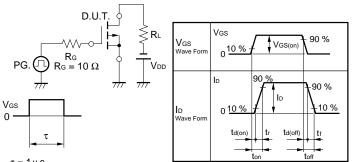
D12968EJ2V0DS00 (2nd edition) May 2001 NS CP(K)

The mark * shows major revised points.

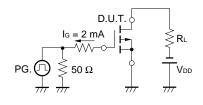
ELECTRICAL CHARACTERISTICS (TA = 25 °C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain Cut-off Current	IDSS	$V_{DS} = -30 V, V_{GS} = 0 V$			-10	μA
Gate Leakage Current	lgss	$V_{GS} = \mp 20 \text{ V}, \text{ Vds} = 0 \text{ V}$			∓ 10	μA
Gate Cut-off Voltage	VGS(off)	$V_{DS} = -10 V$, $I_{D} = -1 mA$	-1.0	-1.7	-2.5	V
Forward Transfer Admittance	yfs	$V_{DS} = -10 V$, $I_D = -1.5 A$	1	3.6		S
Drain to Source On-state Resistance	RDS(on)1	$V_{GS} = -10 V$, $I_D = -1.5 A$		64	85	mΩ
	RDS(on)2	$V_{GS} = -4.5 \text{ V}, \text{ Id} = -1.5 \text{ A}$		114	152	mΩ
	RDS(on)3	$V_{GS} = -4.0 \text{ V}, \text{ Id} = -1.5 \text{ A}$		135	180	mΩ
Input Capacitance	Ciss	$V_{DS} = -10 V$		520		pF
Output Capacitance	Coss	Vgs = 0 V		200		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		82		pF
Turn-on Delay Time	td(on)	$V_{DD} = -10 V$		60		ns
Rise Time	tr	I⊳ = −1.5 A		220		ns
Turn-off Delay Time	td(off)	$V_{GS(on)} = -10 V$		800		ns
Fall Time	tr	$R_G = 10 \Omega$		620		ns
Total Gate Charge	QG	$V_{DD} = -24 V$		12		nC
Gate to Source Charge	Q _{GS}	I⊳ = −2.5 A		2		nC
Gate to Drain Charge	Qgd	V _{GS} = -10 V		3		nC
Diode Forward Voltage	VF(S-D)	IF = 2.5 A, VGS = 0 V		0.73		V

TEST CIRCUIT 1 SWITCHING TIME



TEST CIRCUIT 2 GATE CHARGE

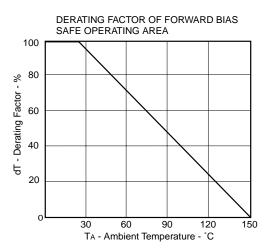


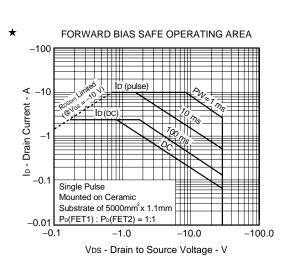
 $\tau = 1\mu s$ Duty Cycle $\leq 1 \%$

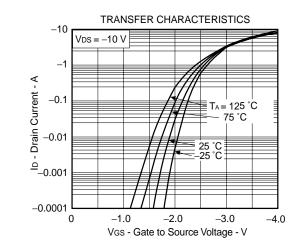
Data Sheet D12968EJ2V0DS

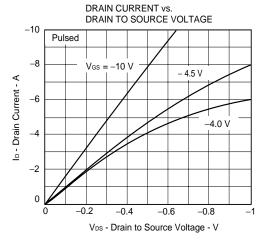
2

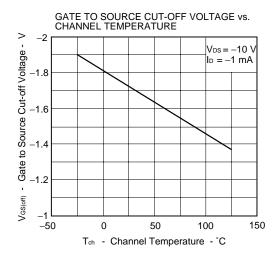


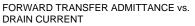


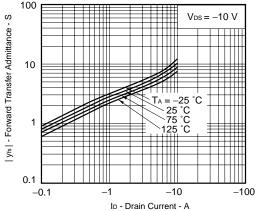




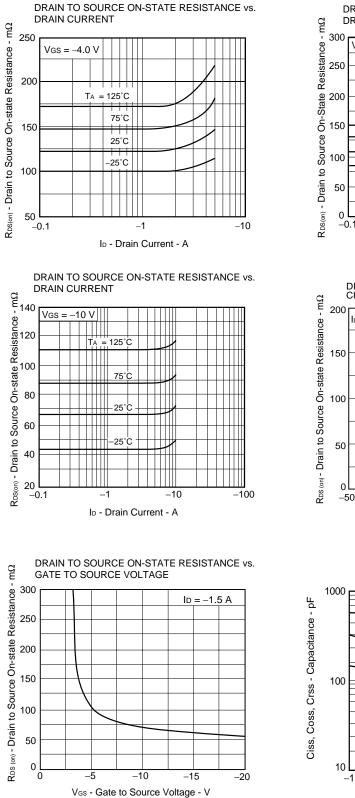




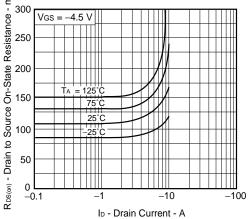




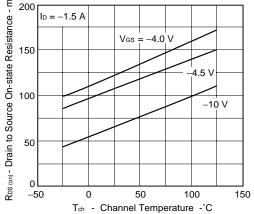
Data Sheet D12968EJ2V0DS

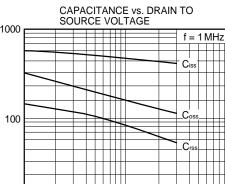


DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT





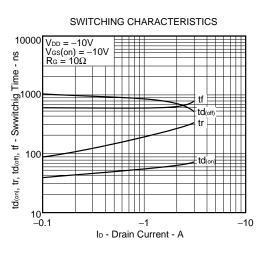




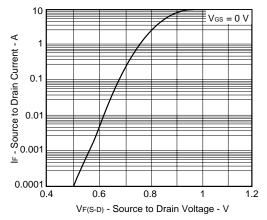
-10 V_{DS} - Drain to Source Voltage - V -100

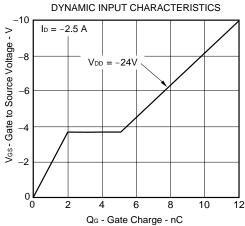
NEC

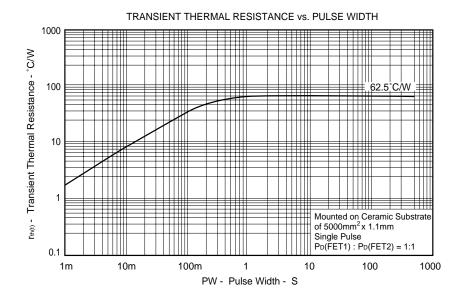
Data Sheet D12968EJ2V0DS











Data Sheet D12968EJ2V0DS

NEC

[MEMO]

NEC

[MEMO]

Data Sheet D12968EJ2V0DS

- The information in this document is current as of May, 2001. The information is subject to change without notice. For actual design-in, refer to the latest publications of NEC's data sheets or data books, etc., for the most up-to-date specifications of NEC semiconductor products. Not all products and/or types are available in every country. Please check with an NEC sales representative for availability and additional information.
- No part of this document may be copied or reproduced in any form or by any means without prior written consent of NEC. NEC assumes no responsibility for any errors that may appear in this document.
- NEC does not assume any liability for infringement of patents, copyrights or other intellectual property rights of third parties by or arising from the use of NEC semiconductor products listed in this document or any other liability arising from the use of such products. No license, express, implied or otherwise, is granted under any patents, copyrights or other intellectual property rights of NEC or others.
- Descriptions of circuits, software and other related information in this document are provided for illustrative purposes in semiconductor product operation and application examples. The incorporation of these circuits, software and information in the design of customer's equipment shall be done under the full responsibility of customer. NEC assumes no responsibility for any losses incurred by customers or third parties arising from the use of these circuits, software and information.
- While NEC endeavours to enhance the quality, reliability and safety of NEC semiconductor products, customers
 agree and acknowledge that the possibility of defects thereof cannot be eliminated entirely. To minimize
 risks of damage to property or injury (including death) to persons arising from defects in NEC
 semiconductor products, customers must incorporate sufficient safety measures in their design, such as
 redundancy, fire-containment, and anti-failure features.
- NEC semiconductor products are classified into the following three quality grades:

"Standard", "Special" and "Specific". The "Specific" quality grade applies only to semiconductor products developed based on a customer-designated "quality assurance program" for a specific application. The recommended applications of a semiconductor product depend on its quality grade, as indicated below. Customers must check the quality grade of each semiconductor product before using it in a particular application.

- "Standard": Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots
- "Special": Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)
- "Specific": Aircraft, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems and medical equipment for life support, etc.

The quality grade of NEC semiconductor products is "Standard" unless otherwise expressly specified in NEC's data sheets or data books, etc. If customers wish to use NEC semiconductor products in applications not intended by NEC, they must contact an NEC sales representative in advance to determine NEC's willingness to support a given application.

(Note)

(1) "NEC" as used in this statement means NEC Corporation and also includes its majority-owned subsidiaries.
 (2) "NEC semiconductor products" means any semiconductor product developed or manufactured by or for NEC (as defined above).

M8E 00.4